

**Notice of References Cited**Application/Control No.  
09/830,875Applicant(s)/Patent Under  
Reexamination  
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1772

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,802,737	02-1989	Denton, Peter R.	359/588
	B	US-4,634,270	01-1987	Yokoo et al.	355/125
	C	US-4,765,729	08-1988	Taniguchi, Takashi	351/163
	D	US-6,329,041	12-2001	Tsuchiya et al.	428/195
	E	US-5,120,605	06-1992	Zuel et al.	216/97
	F	US-6,248,448	06-2001	Lippey et al.	428/432
	G	US-6,111,699	08-2000	Iwata et al.	359/599
	H	US-6,144,479	11-2000	Lugg et al.	348/817
	I	US-6,327,088	12-2001	Iwata et al.	359/452
	J	US-6,392,727	05-2002	Larson et al.	349/117
	K	US-6,379,788	04-2002	Choi et al.	427/164
	L	US-5,835,179	11-1998	Yamanaka, Hideo	349/161
	M	US-6,417,619	07-2002	Yasunori et al.	174/35MS

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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